

Notice of References Cited	Application/Control No. 10/821,859	Applicant(s)/Patent Under Reexamination CHANG, DEUK-HWAN	
	Examiner Kaitlin S. Joerger	Art Unit 3653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,088,717	02-1992	Hamanaka et al.	271/98
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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